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Report Template Version: V03
Report Template Revision Date: Mar.1st, 2017

FCC Test Report

Applicant:	Lief Therapeutics
Address of Applicant:	479 Jessie St. San Francisco, CA, 94103, United States
Manufacturer:	Lief Therapeutics
Address of Manufacturer:	479 Jessie St. San Francisco, CA, 94103, United States
Factory:	Lief Therapeutics
Address of Factory:	479 Jessie St. San Francisco, CA, 94103, United States
Equipment Under Test (EUT):	
Product:	Lief Smart Patch
Model No.:	Lief-01
Brand Name:	Lief Therapeutics
FCC ID:	2ANNN-01
Standards:	47 CFR Part 15, Subpart C
Date of Test:	2017-11-03 to 2017-11-08
Date of Issue:	2017-11-08
Report No. :	CQASZ170901466EW-01
Test Result :	**PASS***

Tested By: Aaron Ma

(Aaron Ma)

Reviewed By: Owen Zhou

(Owen Zhou)

Approved By:

(Jack Ai)

SHENZHEN HUAXIA TESTING TECHNOLOGY CO., LTD 华夏准测 APPROVED

* In the configuration tested, the EUT complied with the standards specified above.

The test report is effective only with both signature and specialized stamp, The result(s) shown in this report refer only to the sample(s) tested. Without written approval of CQA, this report can't be reproduced except in full.

2 Version

Revision History Of Report

Report No.	Version	Description	Issue Date
CQASZ170901466EW-01	Rev.01	Initial report	2017-11-08

3 Test Summary

Test Item	Test Requirement	Test method	Result
Antenna Requirement	47 CFR Part 15, Subpart C Section 15.203/15.247 (c)	ANSI C63.10 2013	PASS
AC Power Line Conducted Emission	47 CFR Part 15, Subpart C Section 15.207	ANSI C63.10 2013	N/A
Conducted Peak Output Power	47 CFR Part 15, Subpart C Section 15.247 (b)(3)	ANSI C63.10 2013	PASS
6dB Occupied Bandwidth	47 CFR Part 15, Subpart C Section 15.247 (a)(2)	ANSI C63.10 2013	PASS
Power Spectral Density	47 CFR Part 15, Subpart C Section 15.247 (e)	ANSI C63.10 2013	PASS
Band-edge for RF Conducted Emissions	47 CFR Part 15, Subpart C Section 15.247(d)	ANSI C63.10 2013	PASS
RF Conducted Spurious Emissions	47 CFR Part 15, Subpart C Section 15.247(d)	ANSI C63.10 2013	PASS
Radiated Spurious Emissions	47 CFR Part 15, Subpart C Section 15.205/15.209	ANSI C63.10 2013	PASS
Restricted bands around fundamental frequency (Radiated Emission)	47 CFR Part 15, Subpart C Section 15.205/15.209	ANSI C63.10 2013	PASS

N/A: Not Applicable, This EUT is battery power

4 Contents

5 General Information

5.1 Client Information

Applicant:	Lief Therapeutics
Address of Applicant:	479 Jessie St. San Francisco, CA, 94103, United States
Manufacturer:	Lief Therapeutics
Address of Manufacturer:	479 Jessie St. San Francisco, CA, 94103, United States
Factory:	Lief Therapeutics
Address of Factory:	479 Jessie St. San Francisco, CA, 94103, United States

5.2 General Description of EUT

Product Name:	Lief Smart Patch
Model No.:	Lief-01
Trade Mark:	Lief Therapeutics
Hardware Version:	V1.0
Software Version:	V1.0
Operation Frequency:	2402MHz~2480MHz
Bluetooth Version:	V4.1 BLE
Modulation Type:	GFSK
Number of Channel:	40
Sample Type:	Portable production
Test Software of EUT:	Nordic Semiconductor Radio Test Software (Manufacturer provide)
Antenna Type:	Ceramic Antenna
Antenna Gain:	-0.5dBi
EUT Power Supply:	For Lief Smart Patch: 5V DC, 0.2A; Battery: DC 3.7V 150mA

Operation Frequency each of channel							
Channel	Frequency	Channel	Frequency	Channel	Frequency	Channel	Frequency
0	2402MHz	10	2422MHz	20	2442MHz	30	2462MHz
1	2404MHz	11	2424MHz	21	2444MHz	31	2464MHz
2	2406MHz	12	2426MHz	22	2446MHz	32	2466MHz
3	2408MHz	13	2428MHz	23	2448MHz	33	2468MHz
4	2410MHz	14	2430MHz	24	2450MHz	34	2470MHz
5	2412MHz	15	2432MHz	25	2452MHz	35	2472MHz
6	2414MHz	16	2434MHz	26	2454MHz	36	2474MHz
7	2416MHz	17	2436MHz	27	2456MHz	37	2476MHz
8	2418MHz	18	2438MHz	28	2458MHz	38	2478MHz
9	2420MHz	19	2440MHz	29	2460MHz	39	2480MHz

Note:
In section 15.31(m), regards to the operating frequency range over 10 MHz, the lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, and the selected channel see below:

Channel	Frequency
The lowest channel (CH0)	2402MHz
The middle channel (CH19)	2440MHz
The highest channel (CH39)	2480MHz

5.3 Test Environment

Operating Environment:	
Temperature:	25.0 °C
Humidity:	53 % RH
Atmospheric Pressure:	1010mbar
Test Mode:	Use test software (Nordic Semiconductor Radio Test Software) to set the lowest frequency, the middle frequency and the highest frequency keep transmitting of the EUT. Note: In the process of transmitting of EUT, the duty cycle ＞98%.

5.4 Description of Support Units

The EUT has been tested with associated equipment below.

Description	Manufacturer	Model No.	Remark	FCC certification
/	/	/	/	/

5.5 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate.

The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities.

The measurement uncertainty was calculated for all measurements listed in this test report acc. to CISPR 16 - 4 „Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainty in EMC Measurements“ and is documented in the **Shenzhen Tongce Testing Lab** quality system acc. to DIN EN ISO/IEC 17025.

Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for **TCT** laboratory is reported:

Item	Uncertainty	Notes
All emissions, radiated(<1GHz)	±3.92dB	(1)
All emissions, radiated(>1GHz)	±4.28dB	(1)
Conducted Disturbance	±2.56dB	(1)
Spurious emissions, conducted	±0.11dB	(1)
RF power, conducted	±0.12dB	(1)
Temperature	±0.1°C	(1)
Humidity	±1.0%	(1)

(1)This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

5.6 Test Location

Shenzhen Tongce Testing Lab,

1B/F., Building 1, Yibaolai Industrial Park, Qiaotou, Fuyong, Baoan District, Shenzhen, Guangdong, China

5.7 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:
FCC – Registration No.: 645098
Shenzhen Tongce Testing Lab
The 3m Semi-anechoic chamber has been registered and fully described in a report with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files.

5.8 Deviation from Standards

None.

5.9 Abnormalities from Standard Conditions

None.

5.10 Other Information Requested by the Customer

None.

5.11Equipment List

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Calibration Due. Date
1	EMI Test Receiver	R&S	ESVD	100008	2018/09/27
2	Spectrum Analyzer	R&S	FSQ	200061	2018/09/27
3	Pre-amplifier	EM Electronics Corporation CO.,LTD	EM30265	07032613	2018/09/27
4	Pre-amplifier	HP	8447D	2727A05017	2018/09/27
5	Loop antenna	ZHINAN	ZN30900A	12024	2018/09/27
6	Broadband Antenna	Schwarzbeck	VULB9163	340	2018/09/27
7	Horn Antenna	Schwarzbeck	BBHA 9120D	631	2018/09/27
8	Horn Antenna	Schwarzbeck	BBHA 9170	582	2018/06/07
9	Antenna Mast	CCS	CC-A-4M	N/A	N/A
10	Coax cable (9KHz~40GHz)	TCT	RE-low-01	N/A	2018/09/27
11	Coax cable (9KHz~40GHz)	TCT	RE-high-02	N/A	2018/09/27
12	Spectrum Analyzer	R&S	FSU	200054	2018/09/27
13	Antenna Connector	TCT	RFC-01	N/A	2018/09/27
14	RF cable (9KHz~26.25GHz)	TCT	RE-06	N/A	2018/09/27
15	LISN	R&S	NSLK 8126	8126453	2018/09/27

Note:

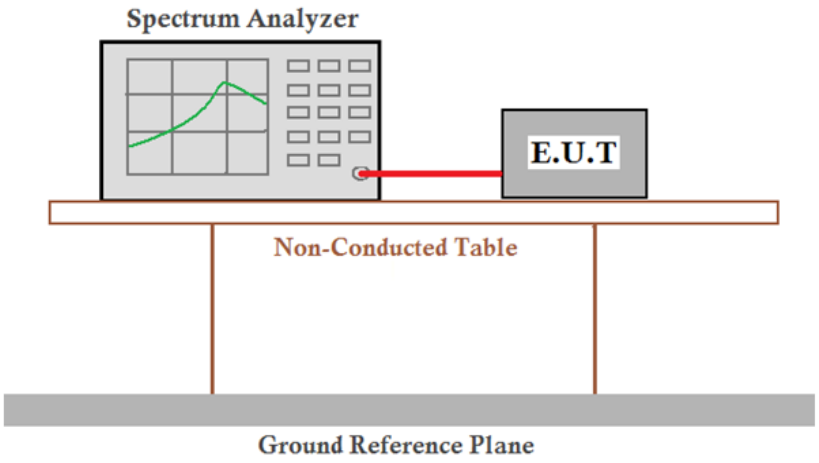
The temporary antenna connector is soldered on the PCB board in order to perform conducted tests and this temporary antenna connector is listed in the equipment list.

6 Test results and Measurement Data

6.1 Antenna Requirement

Standard requirement:	47 CFR Part 15C Section 15.203 /247(c)
15.203 requirement: An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited. 15.247(b) (4) requirement: The conducted output power limit specified in paragraph (b) of this section is based on the use of antennas with directional gains that do not exceed 6 dBi. Except as shown in paragraph (c) of this section, if transmitting antennas of directional gain greater than 6 dBi are used, the conducted output power from the intentional radiator shall be reduced below the stated values in paragraphs (b)(1), (b)(2), and (b)(3) of this section, as appropriate, by the amount in dB that the directional gain of the antenna exceeds 6 dBi.	
EUT Antenna:	
The antenna is integrated on the main PCB and no consideration of replacement. The best case gain of the antenna is -0.5 dBi.	

6.2 Conducted Peak Output Power

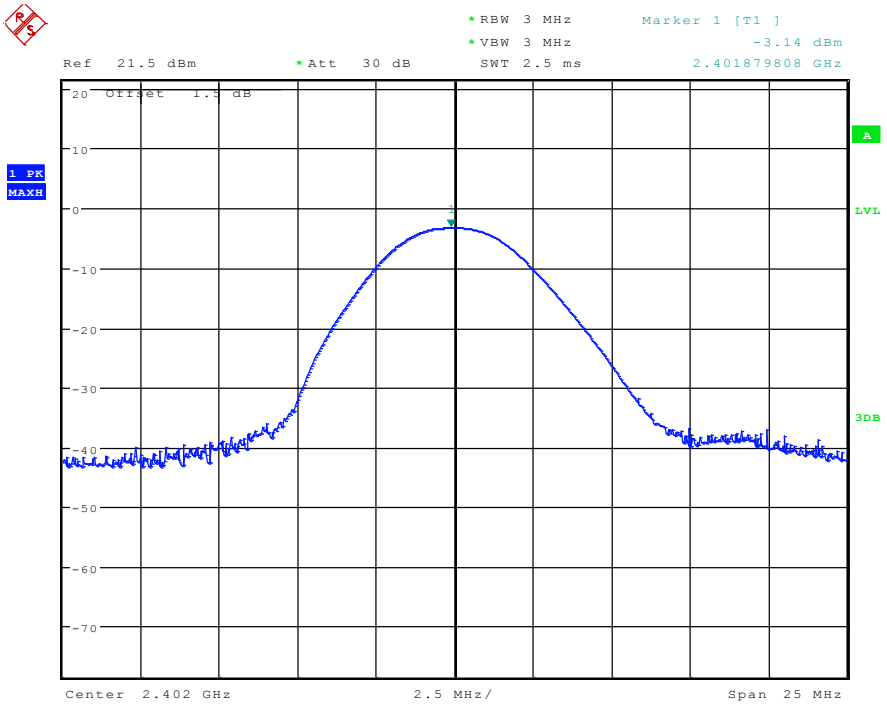
Test Requirement:	47 CFR Part 15C Section 15.247 (b)(1)
Test Method:	ANSI C63.10 2013
Test Setup:	 *Remark:* *Offset the High-Frequency cable loss 1.5dB in the spectrum analyzer.*
Limit:	30dBm
Test Mode:	Transmitting with GFSK modulation.
Instruments Used:	Refer to section 5.11 for details.
Test Results:	Pass

Measurement Data

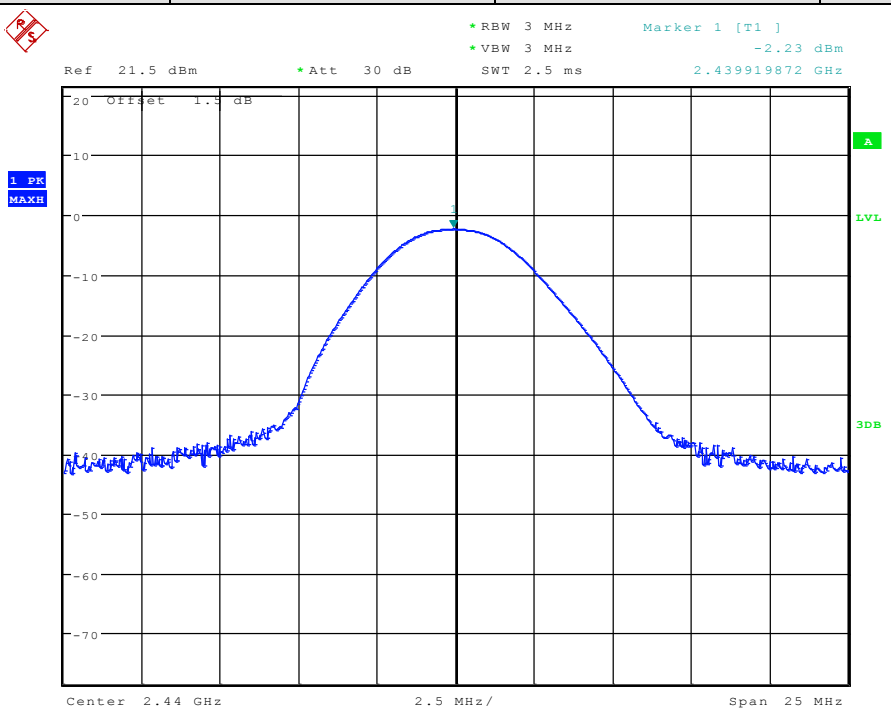
GFSK mode			
Test channel	Peak Output Power (dBm)	Limit (dBm)	Result
Lowest	-3.14	30.00	Pass
Middle	-2.23	30.00	Pass
Highest	-2.09	30.00	Pass

Test plot as follows:

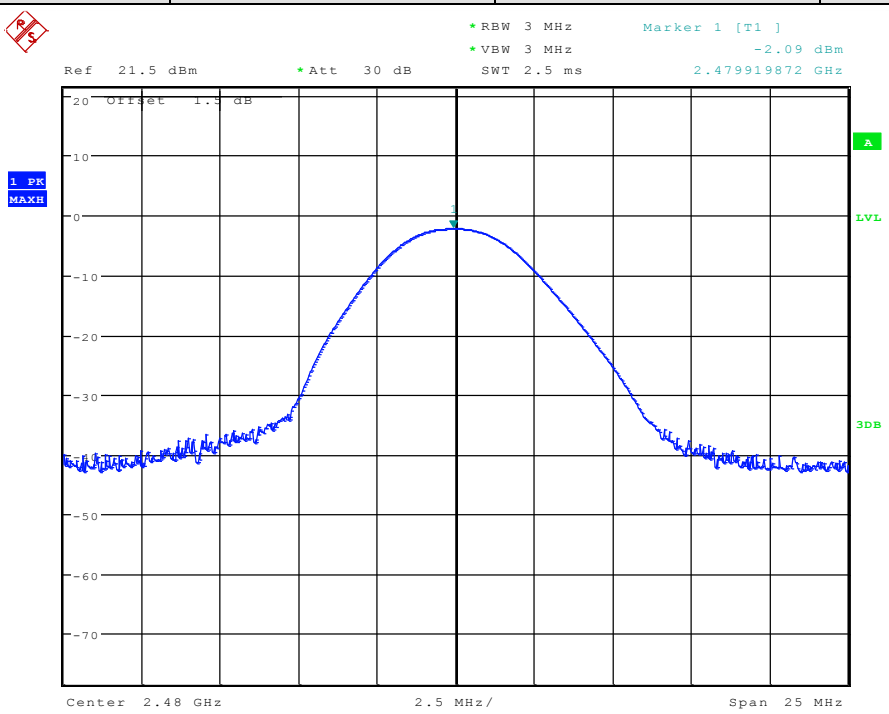
Test mode:	GFSK	Test channel:	Lowest



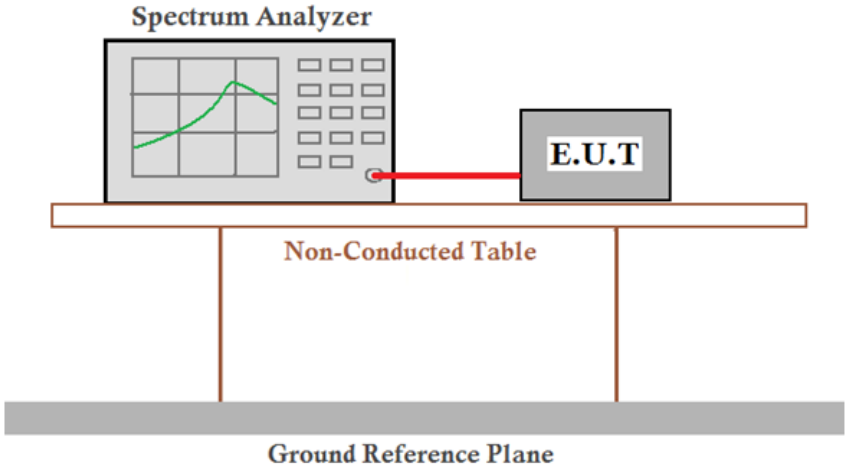
Test mode:	GFSK	Test channel:	Middle



Test mode:	GFSK	Test channel:	Highest



6.3 6dB Occupy Bandwidth

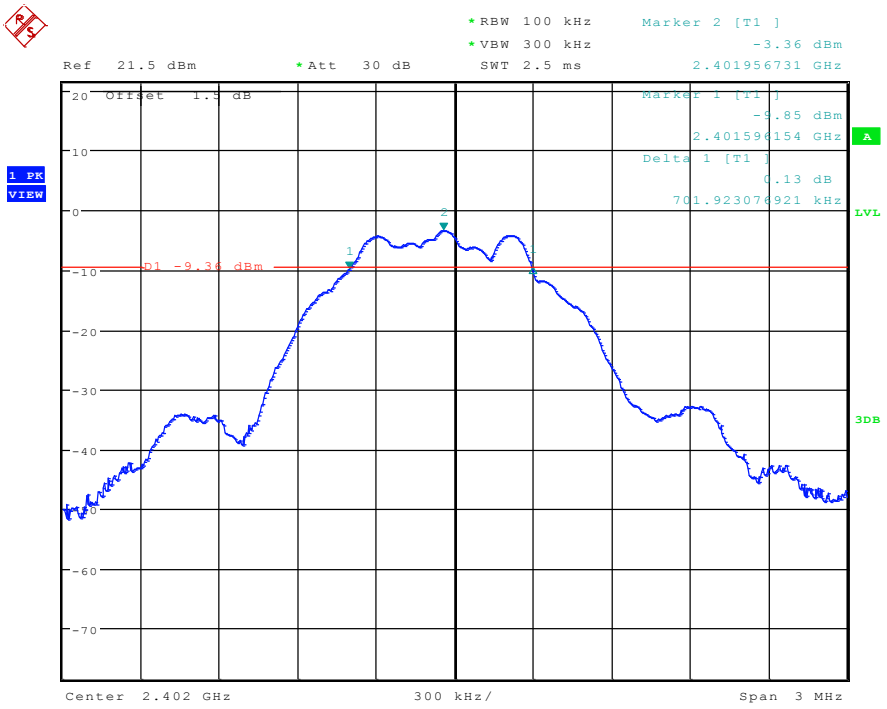
Test Requirement:	47 CFR Part 15C Section 15.247 (a)(2)
Test Method:	ANSI C63.10 2013
Test Setup:	
Limit:	≥ 500 kHz
Test Mode:	Transmitting with GFSK modulation.
Instruments Used:	Refer to section 5.11 for details.
Test Results:	Pass

Measurement Data

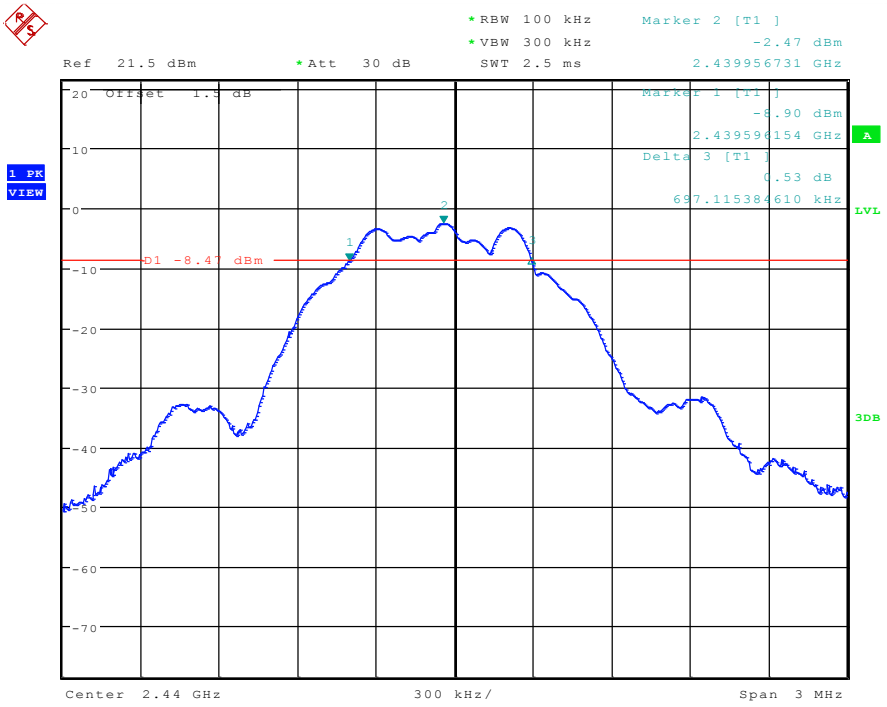
GFSK mode			
Test channel	6dB Occupy Bandwidth (MHz)	Limit (kHz)	Result
Lowest	0.702	≥500	Pass
Middle	0.697	≥500	Pass
Highest	0.692	≥500	Pass

Test plot as follows:

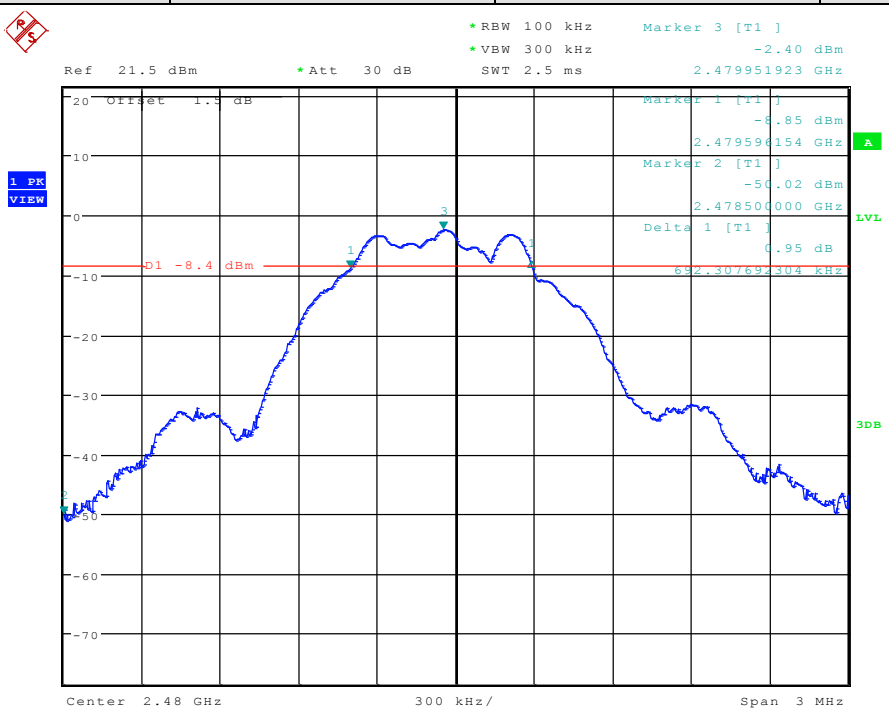
Test mode:	GFSK	Test channel:	Lowest



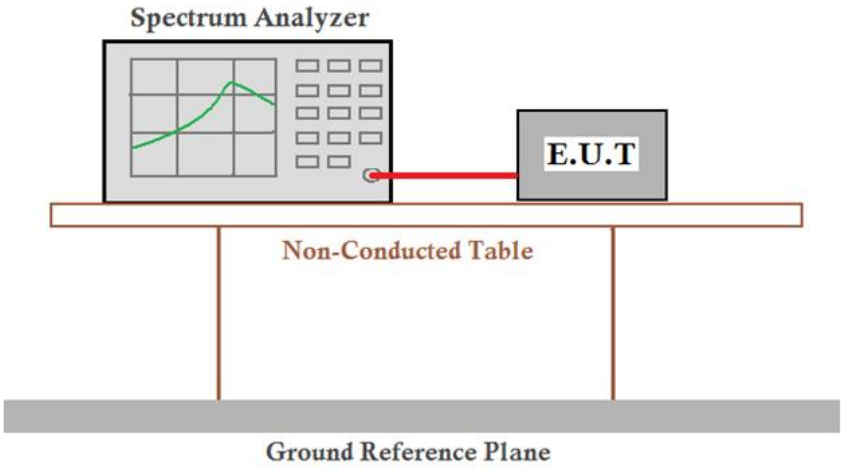
Test mode:	GFSK	Test channel:	Middle



Test mode:	GFSK	Test channel:	Highest



6.4 Power Spectral Density

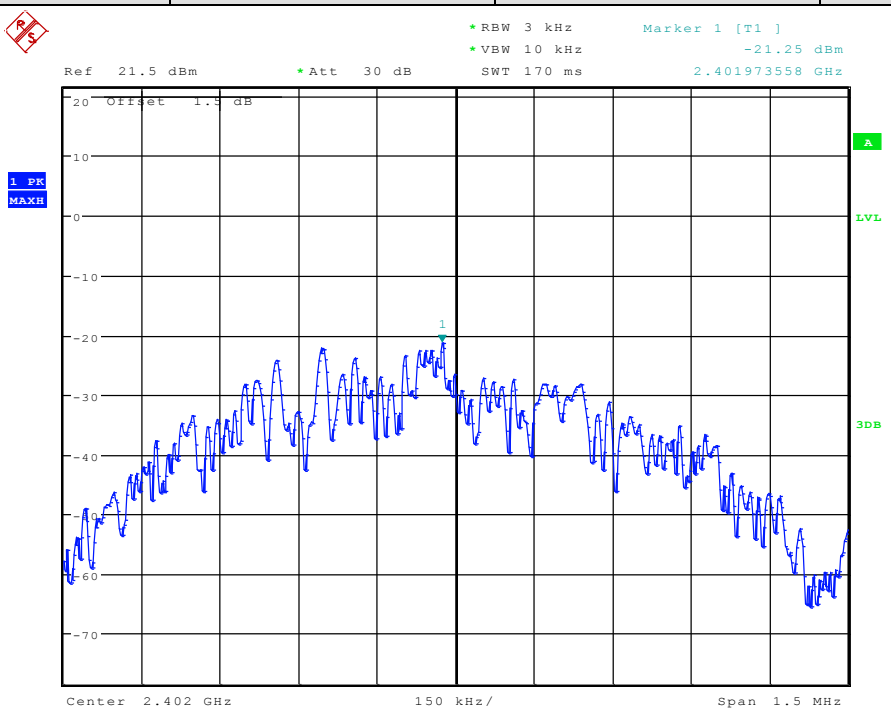
Test Requirement:	47 CFR Part 15C Section 15.247 (e)
Test Method:	ANSI C63.10 2013
Test Setup:	
Limit:	≤8.00dBm/3kHz
Test Mode:	Transmitting with GFSK modulation.
Instruments Used:	Refer to section 5.11 for details.
Test Results:	Pass

Measurement Data

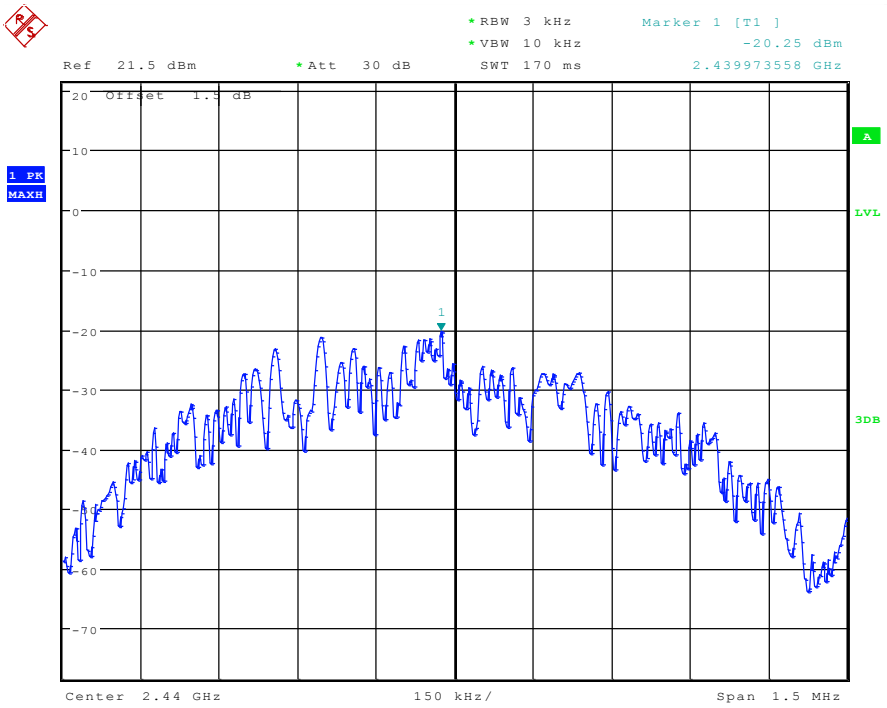
GFSK mode			
Test channel	Power Spectral Density (dBm/3kHz)	Limit (dBm/3kHz)	Result
Lowest	-21.25	≤8.00	Pass
Middle	-20.25	≤8.00	Pass
Highest	-20.27	≤8.00	Pass

Test plot as follows:

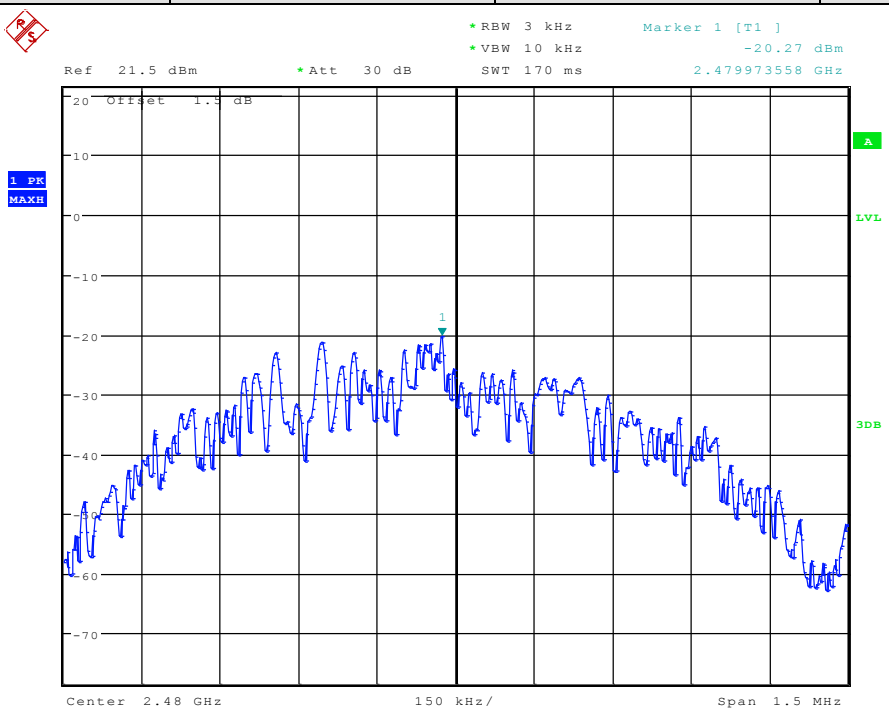
Test mode:	GFSK	Test channel:	Lowest



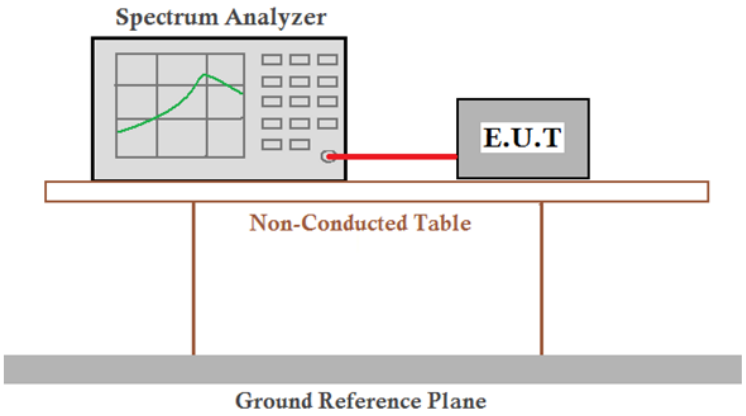
Test mode:	GFSK	Test channel:	Middle



Test mode:	GFSK	Test channel:	Highest



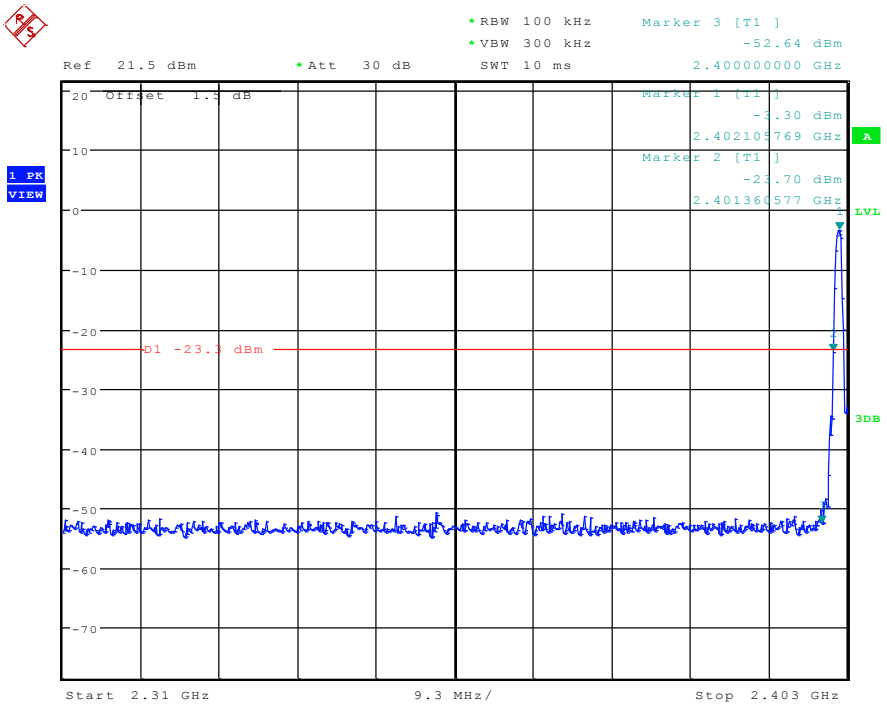
6.5 Band-edge for RF Conducted Emissions

Test Requirement:	47 CFR Part 15C Section 15.247 (d)
Test Method:	ANSI C63.10 2013
Test Setup:	 Remark: Offset the High-Frequency cable loss 1.5dB in the spectrum analyzer.
Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement.
Test Mode:	Transmitting with GFSK modulation.
Instruments Used:	Refer to section 5.11 for details.
Test Results:	Pass

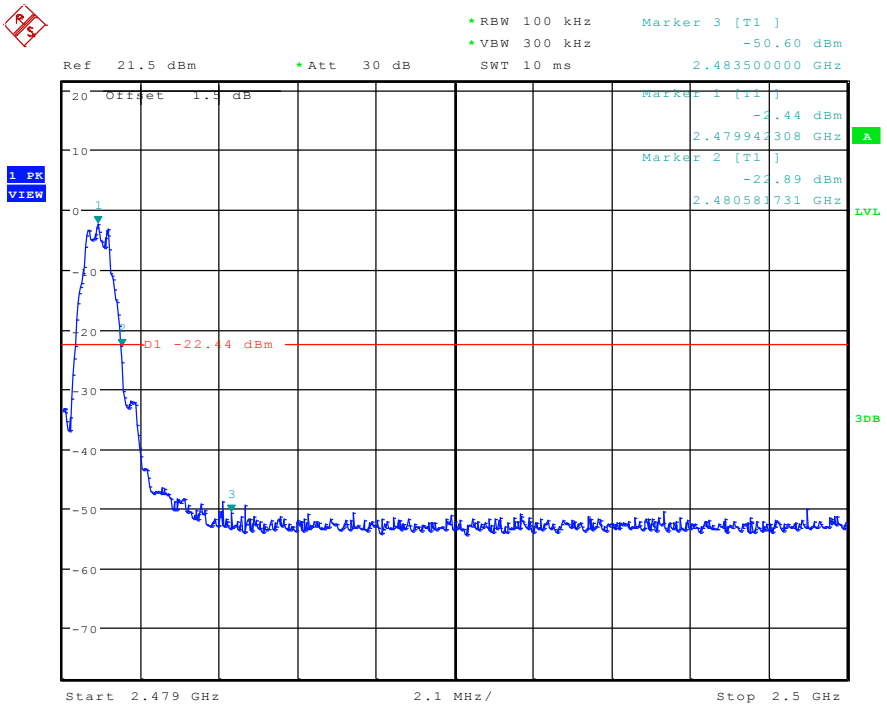
GFSK mode				
Test channel	Frequency(MHz)	Emission Level(dBm)	Limit(dBm)	Result
Lowest	2400	-52.64	-23.3	Pass
Highest	2483.5	-50.60	-22.44	Pass

Test plot as follows:

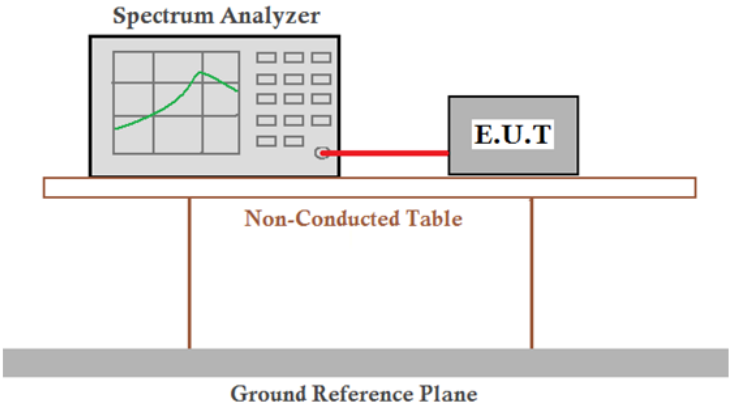
Test mode:	GFSK	Test channel:	Lowest



Test mode:	GFSK	Test channel:	Highest

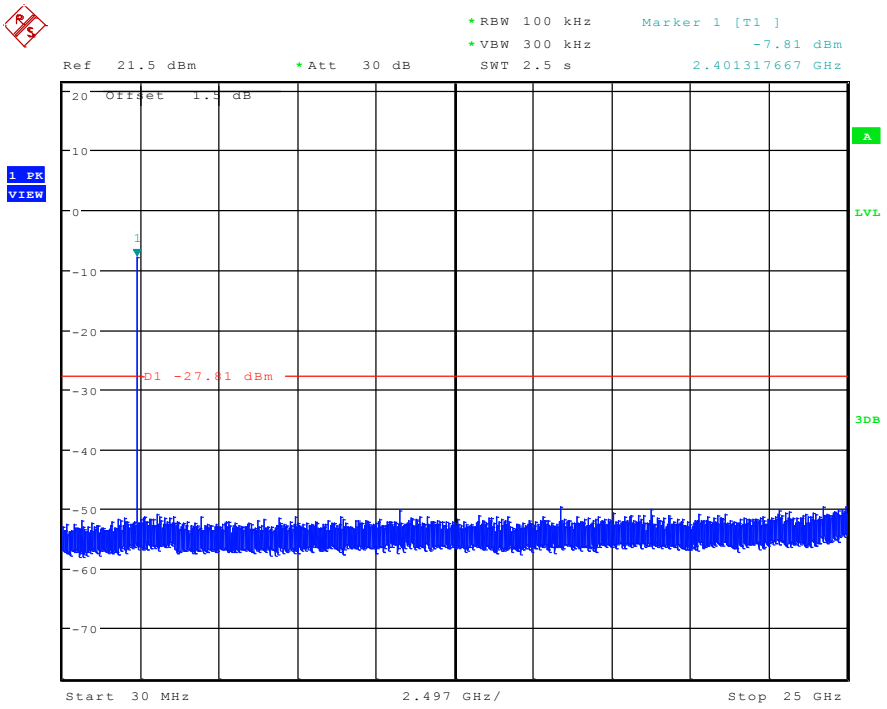


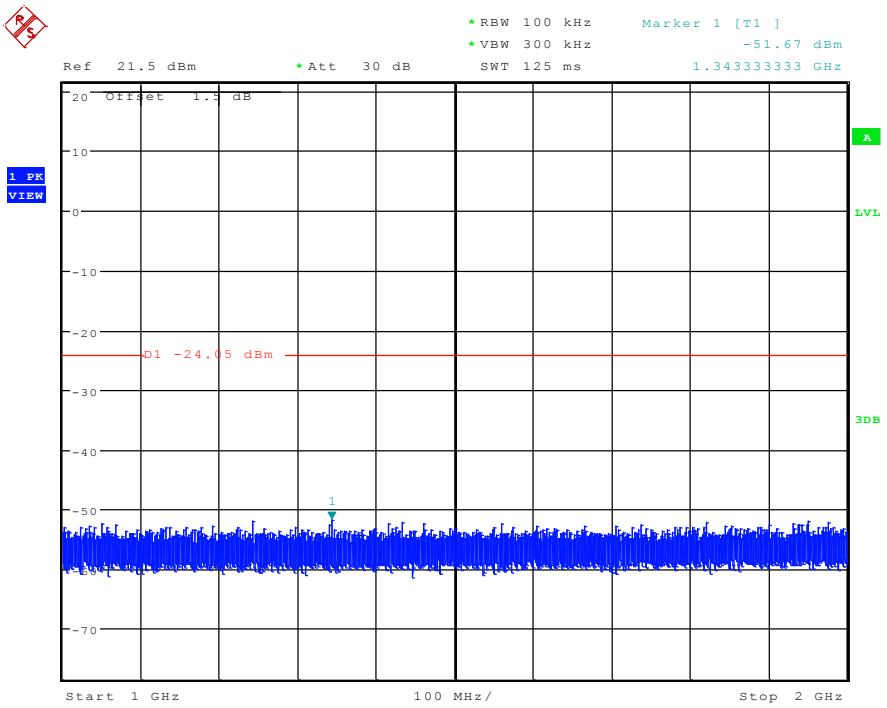
6.6 Spurious RF Conducted Emissions

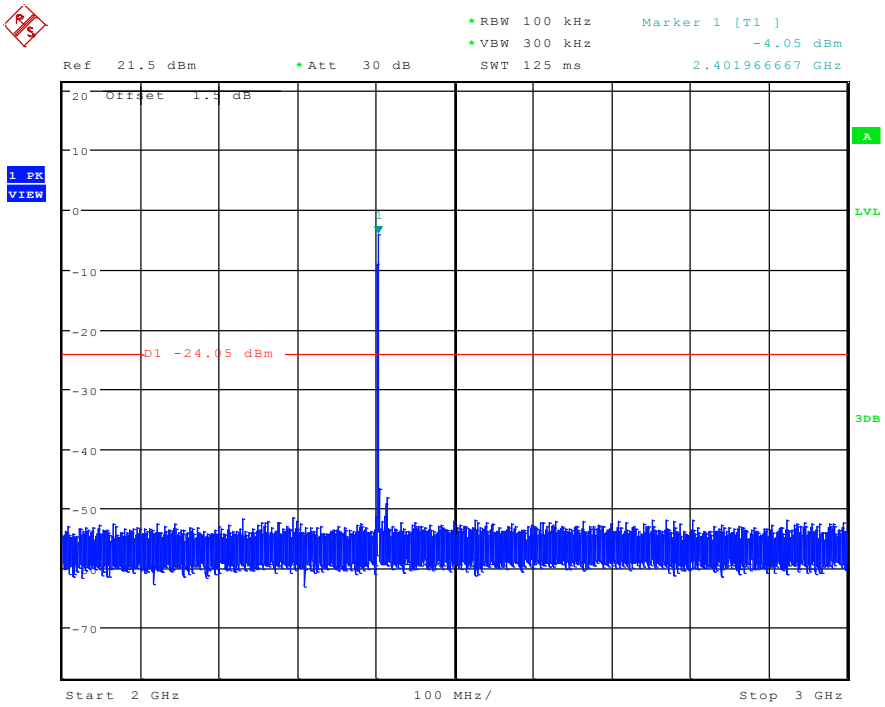
Test Requirement:	47 CFR Part 15C Section 15.247 (d)
Test Method:	ANSI C63.10 2013
Test Setup:	 Remark: Offset the High-Frequency cable loss 1.5dB in the spectrum analyzer.
Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement.
Test Mode:	Transmitting with GFSK modulation.
Instruments Used:	Refer to section 5.11 for details.
Test Results:	Pass

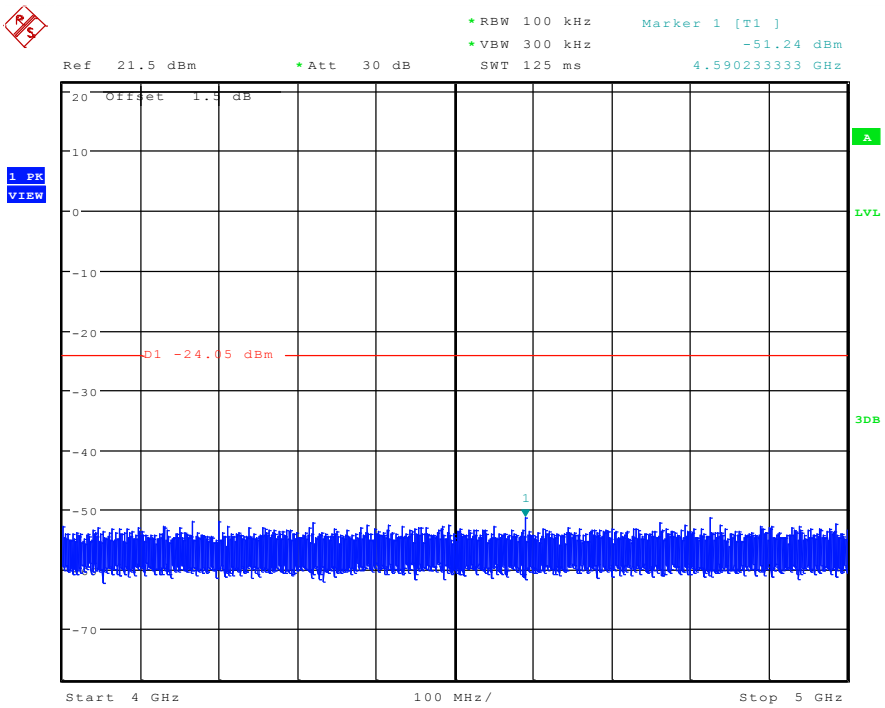
Test plot as follows:

Test mode:	GFSK	Test channel:	Lowest

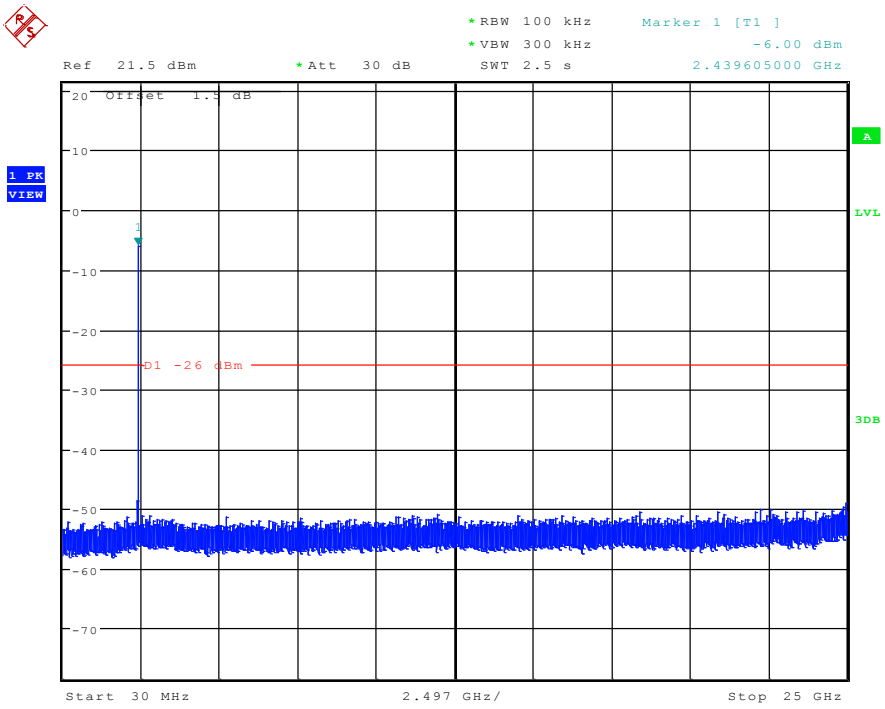


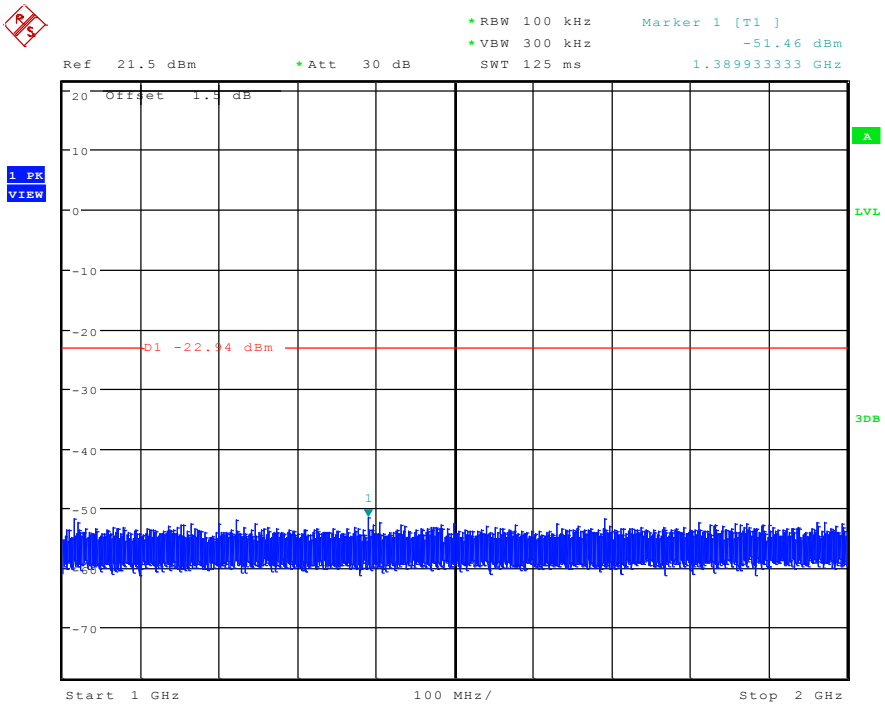


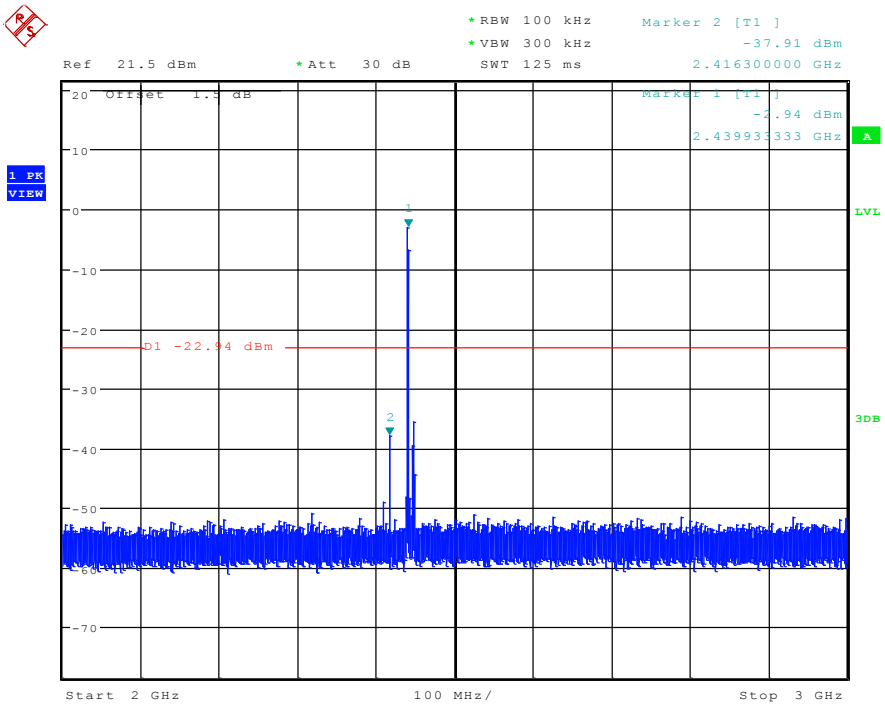

RBW 100 kHz
VBW 300 kHz
SWT 125 ms
Marker 1 [T1]
-4.05 dBm
2.401966667 GHz
Ref 21.5 dBm
Att 30 dB
Offset 1.5 dB
1 PK
VIEW
A
LVL
3DB
D1 -24.05 dBm
Start 2 GHz
100 MHz/
Stop 3 GHz

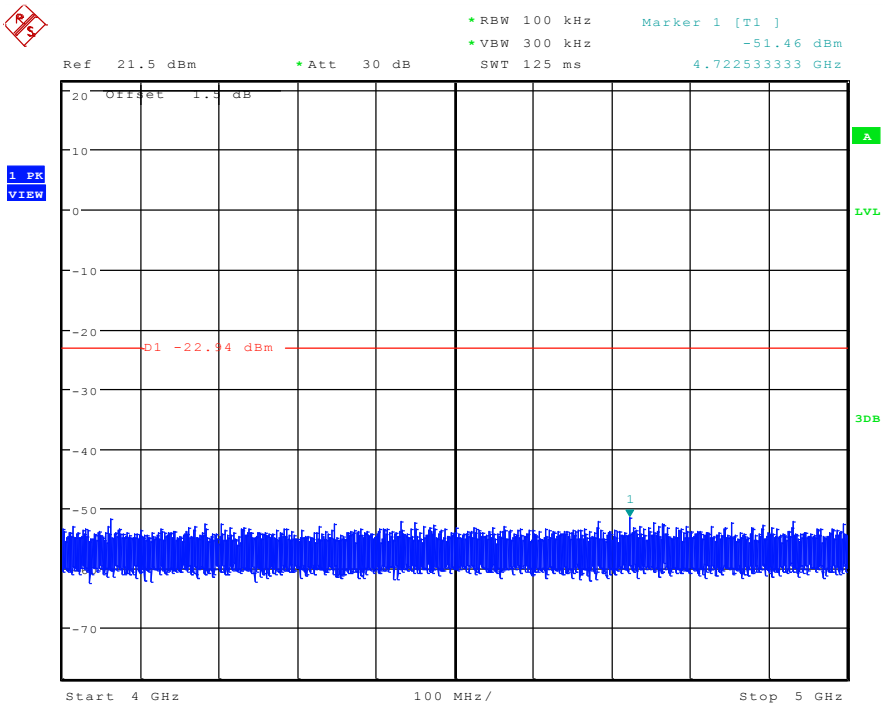

RBW 100 kHz
VBW 300 kHz
SWT 125 ms
Marker 1 [T1]
-51.24 dBm
4.590233333 GHz
Ref 21.5 dBm
Att 30 dB
Offset 1.5 dB
1 PK
VIEW
A
LVL
3DB
D1 -24.05 dBm
Start 4 GHz
100 MHz/
Stop 5 GHz

Test mode:	GFSK	Test channel:	Middle

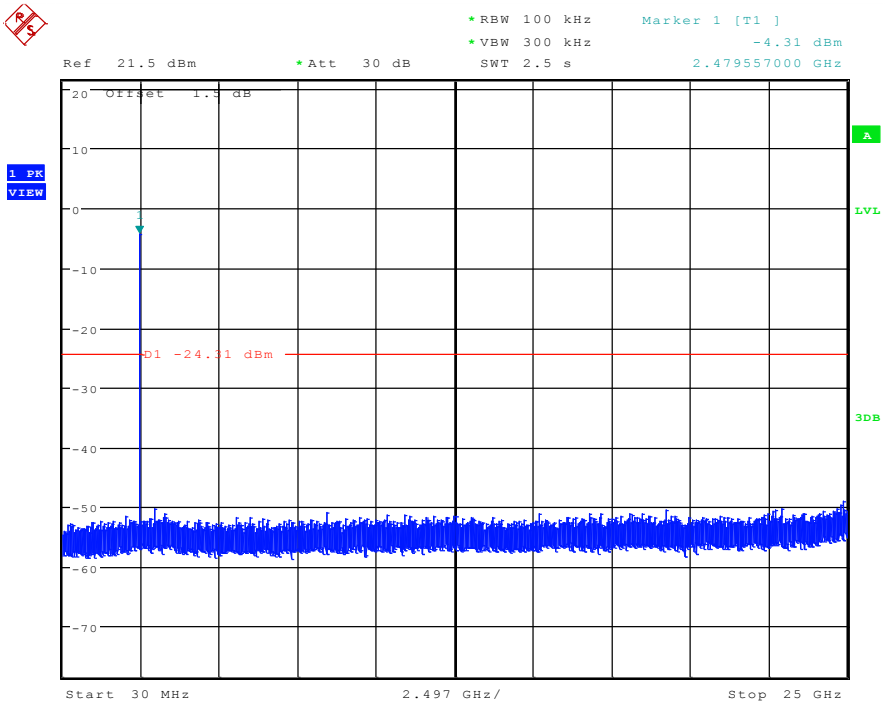


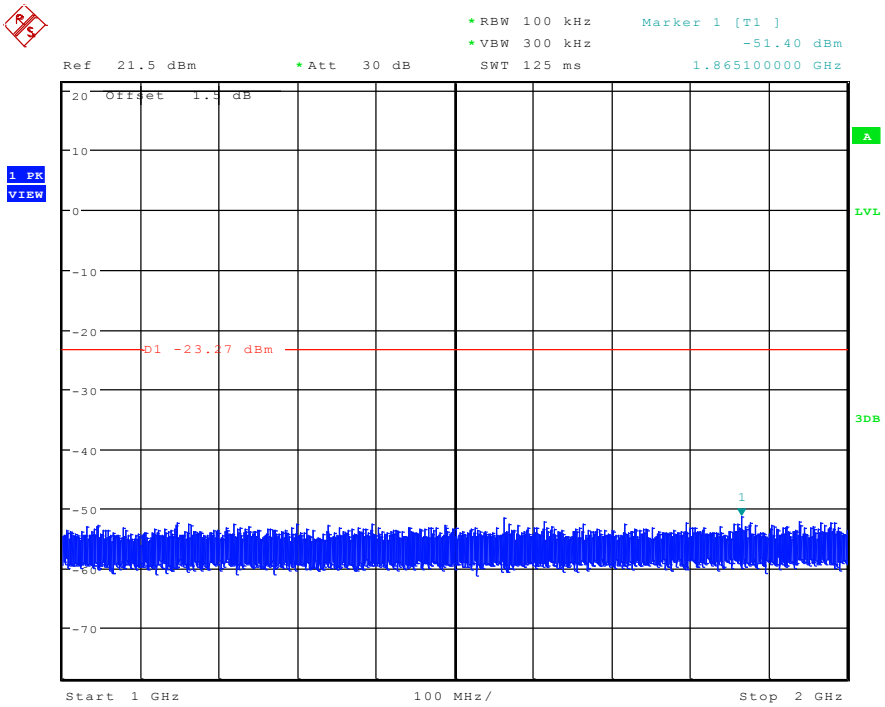


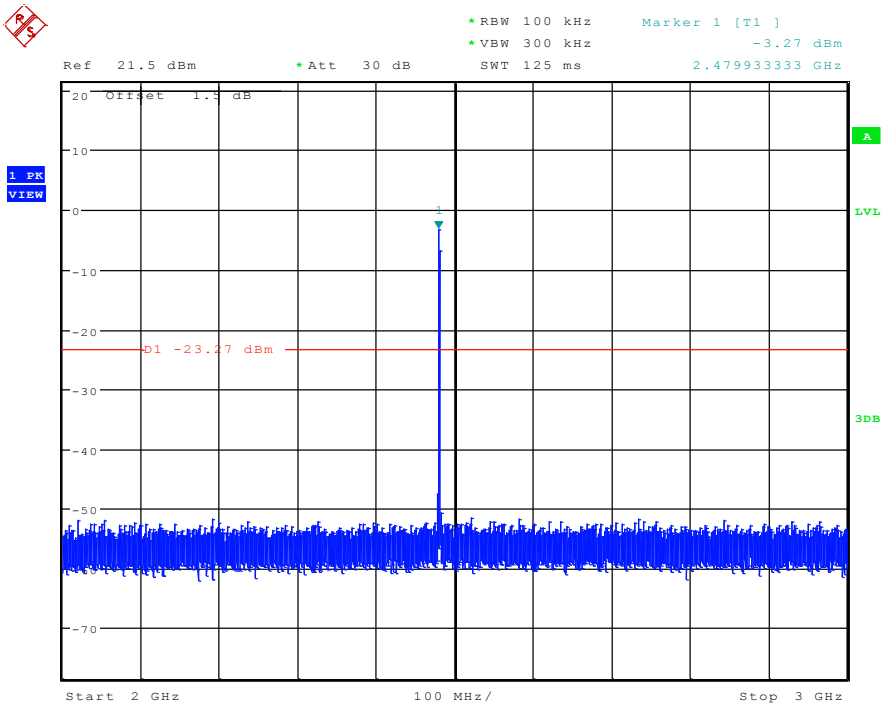

RBW 100 kHz
VBW 300 kHz
SWT 125 ms
Marker 2 [T1]
-37.91 dBm
2.416300000 GHz
Ref 21.5 dBm
Att 30 dB
Offset 1.5 dB
Marker 1 [T1]
-2.94 dBm
2.439933333 GHz
1 PK
VIEW
A
LVL
3DB
D1 -22.94 dBm
Start 2 GHz
100 MHz/
Stop 3 GHz

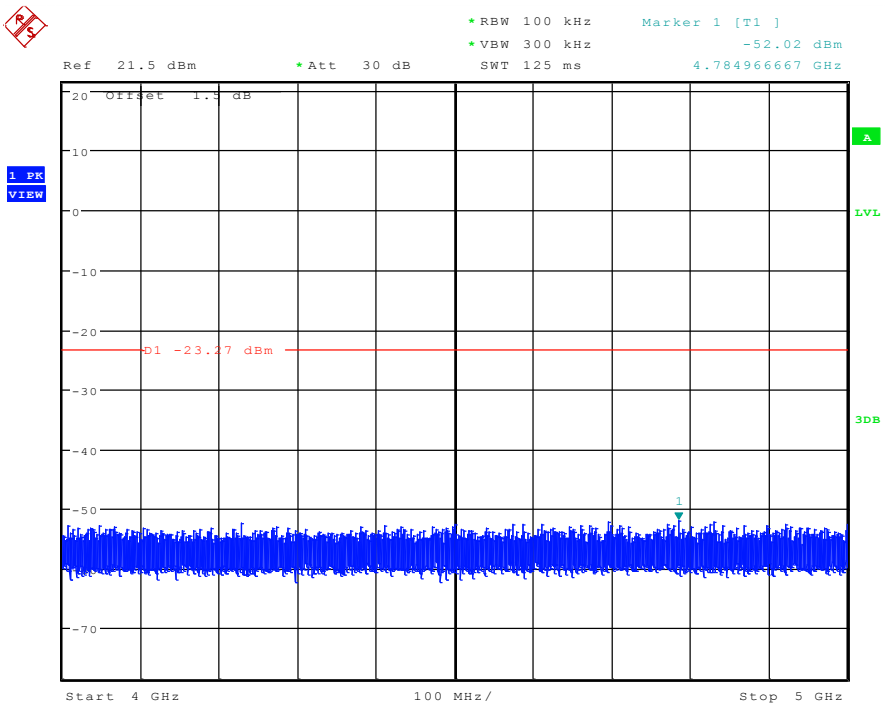

RBW 100 kHz
VBW 300 kHz
SWT 125 ms
Marker 1 [T1]
-51.46 dBm
4.722533333 GHz
Ref 21.5 dBm
Att 30 dB
Offset 1.5 dB
1 PK
VIEW
A
LVL
3DB
D1 -22.94 dBm
Start 4 GHz
100 MHz/
Stop 5 GHz

Test mode:	GFSK	Test channel:	Highest









Remark:

Pretest 9kHz to 25GHz, find the highest point when testing, so only the worst data were shown in the test report. Per FCC Part 15.33 (a) and 15.31 (o) ,The amplitude of spurious emissions from intentional radiators which are attenuated more than 20 dB below the permissible value need not be reported unless specifically required elsewhere in this part.

6.7 Radiated Spurious Emission & Restricted bands

6.7.1 Spurious Emissions

Test Requirement:	47 CFR Part 15C Section 15.209 and 15.205
Test Method:	ANSI C63.10 2013
Test Site:	Measurement Distance: 3m (Semi-Anechoic Chamber)

Receiver Setup:

Frequency	Detector	RBW	VBW	Remark
0.009MHz-0.090MHz	Peak	10kHz	30kHz	Peak
0.009MHz-0.090MHz	Average	10kHz	30kHz	Average
0.090MHz-0.110MHz	Quasi-peak	10kHz	30kHz	Quasi-peak
0.110MHz-0.490MHz	Peak	10kHz	30kHz	Peak
0.110MHz-0.490MHz	Average	10kHz	30kHz	Average
0.490MHz -30MHz	Quasi-peak	10kHz	30kHz	Quasi-peak
30MHz-1GHz	Quasi-peak	100 kHz	300kHz	Quasi-peak
Above 1GHz	Peak	1MHz	3MHz	Peak
	Peak	1MHz	10Hz	Average

Limit:

Frequency	Field strength (microvolt/meter)	Limit (dBuV/m)	Remark	Measurement distance (m)
0.009MHz-0.490MHz	2400/F(kHz)	-	-	300
0.490MHz-1.705MHz	24000/F(kHz)	-	-	30
1.705MHz-30MHz	30	-	-	30
30MHz-88MHz	100	40.0	Quasi-peak	3
88MHz-216MHz	150	43.5	Quasi-peak	3
216MHz-960MHz	200	46.0	Quasi-peak	3
960MHz-1GHz	500	54.0	Quasi-peak	3
Above 1GHz	500	54.0	Average	3

Note: 15.35(b), Unless otherwise specified, the limit on peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. This peak limit applies to the total peak emission level radiated by the device.

Test Setup:	

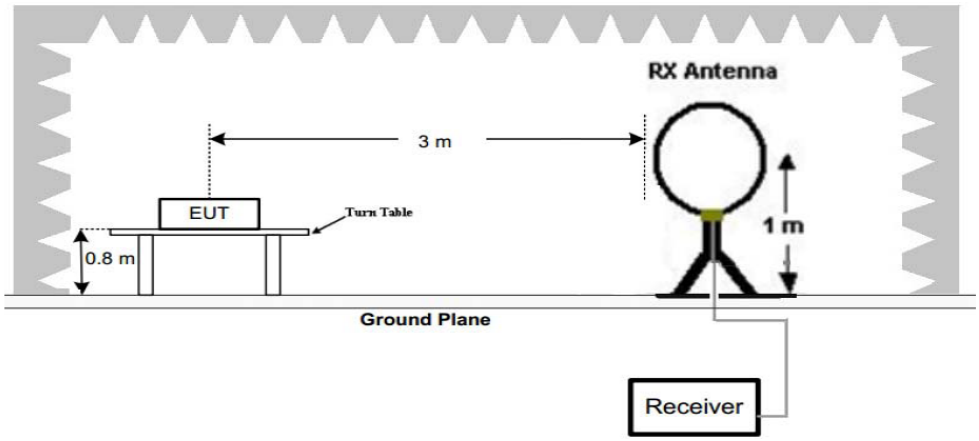


Figure 1. Below 30MHz

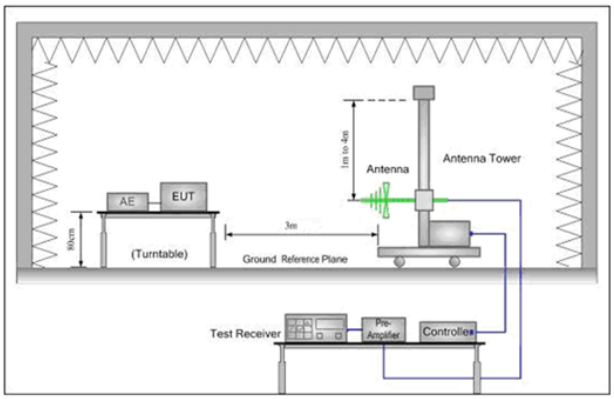


Figure 2. 30MHz to 1GHz

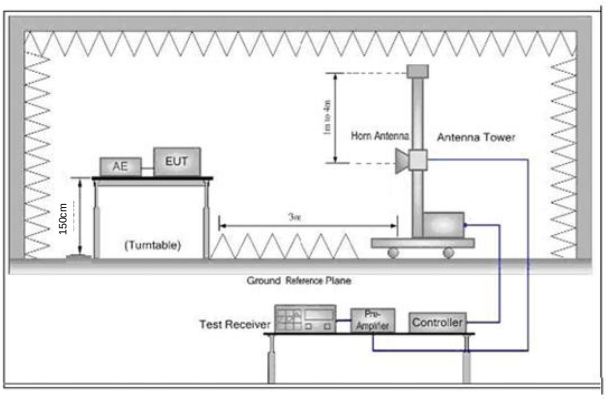
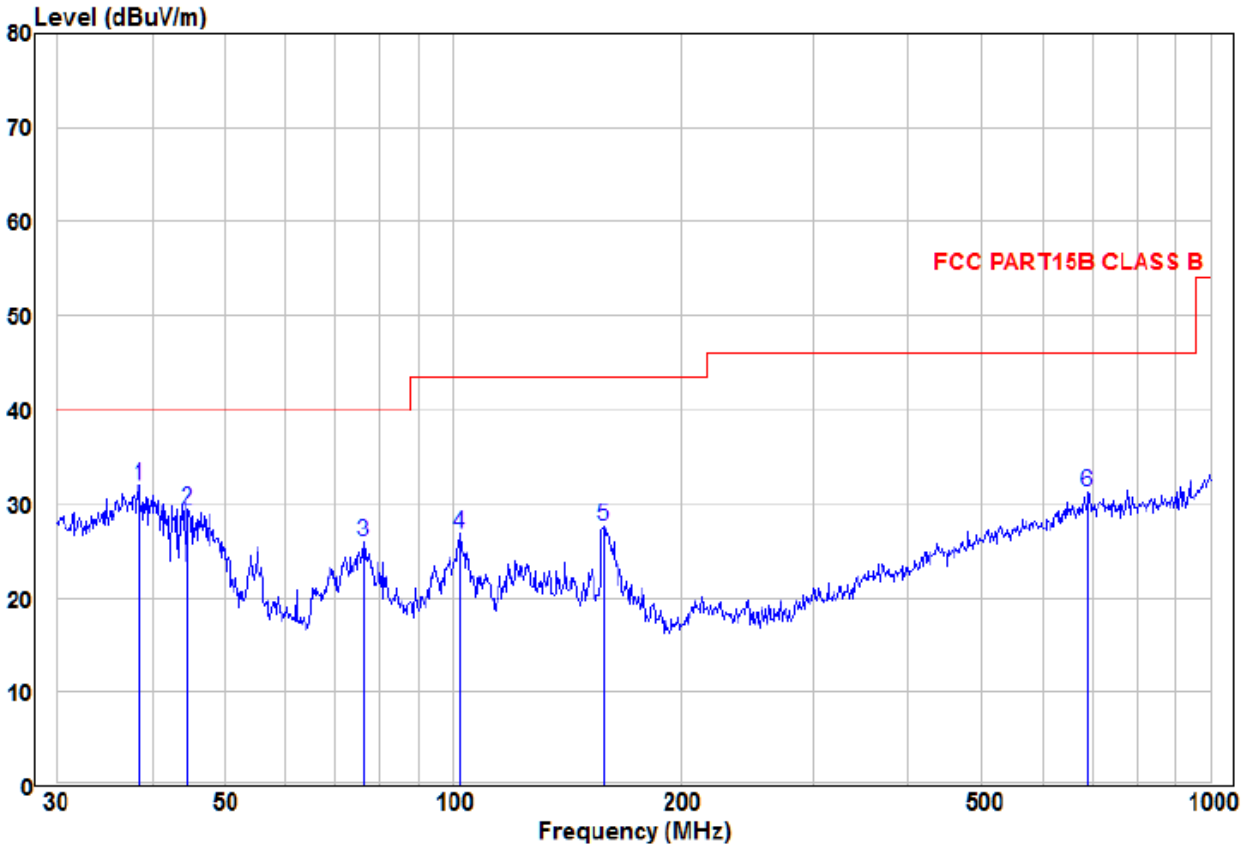


Figure 3. Above 1 GHz

Test Procedure:	a. 1) Below 1G: The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter semi-anechoic camber. The table was rotated 360 degrees to determine the position of the highest radiation. 2) Above 1G: The EUT was placed on the top of a rotating table 1.5 meters above the ground at a 3 meter semi-anechoic camber. The table was rotated 360 degrees to determine the position of the highest radiation. Note: For the radiated emission test above 1GHz: Place the measurement antenna away from each area of the EUT determined to be a source of emissions at the specified measurement distance, while keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response. The measurement antenna may have to be higher or lower than the EUT, depending on the radiation pattern of the emission and staying aimed at the emission source for receiving the maximum signal. The final measurement antenna elevation shall be that which maximizes the emissions. The measurement antenna elevation for maximum emissions shall be restricted to a range of heights of from 1 m to 4 m above the ground or reference ground plane. b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower. c. The antenna height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the

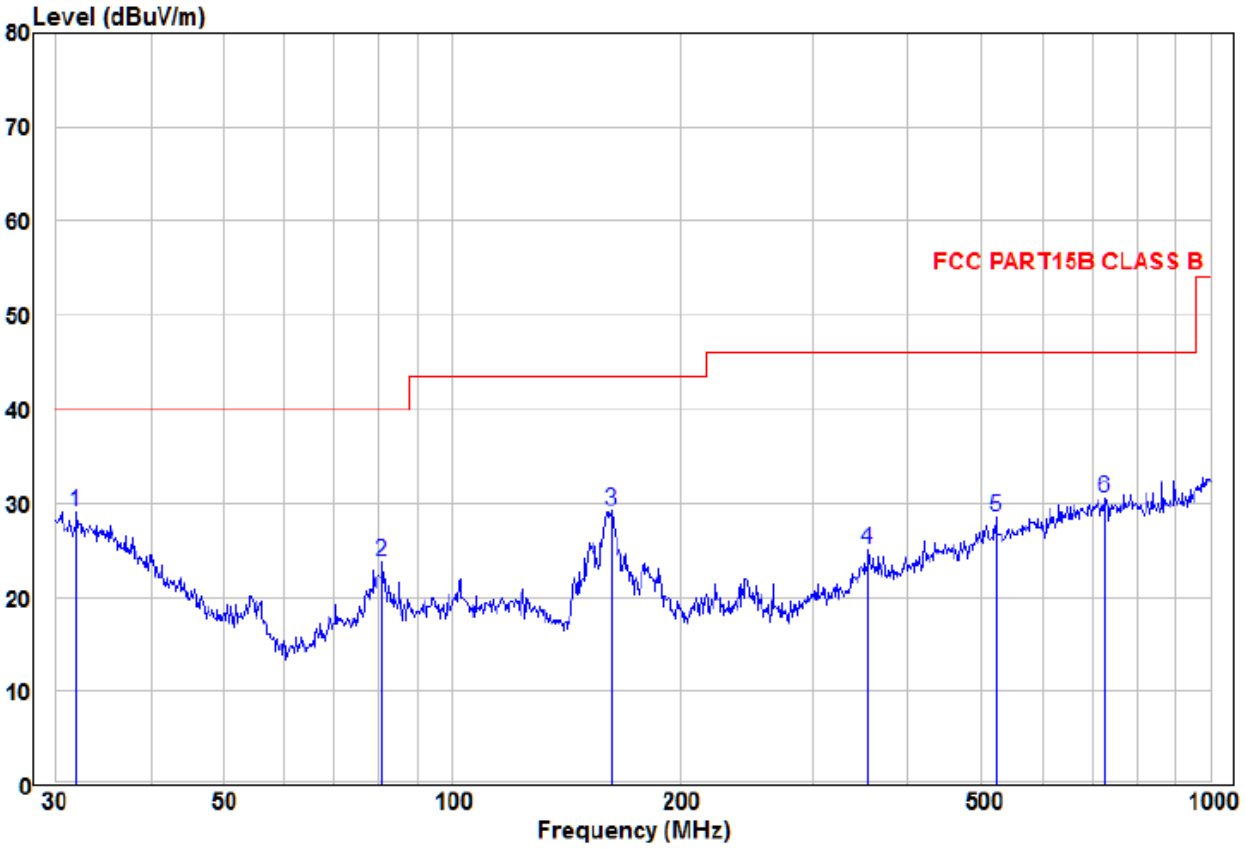
	measurement. d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading. e. The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode. f. If the emission level of the EUT in peak mode was 10dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emissions that did not have 10dB margin would be re-tested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet. g. Test the EUT in the lowest channel (2402MHz),the middle channel (2440MHz),the Highest channel (2480MHz) h. The radiation measurements are performed in X, Y, Z axis positioning for Transmitting mode, and found the X axis positioning which it is the worst case. i. Repeat above procedures until all frequencies measured was complete.
Exploratory Test Mode:	Transmitting with GFSK modulation. Transmitting mode.
Final Test Mode:	Transmitting with GFSK modulation. Pretest the EUT at Transmitting mode, found the Transmitting mode which it is worse case. For below 1GHz part, through pre-scan, the worst case is the lowest channel. Only the worst case is recorded in the report.
Instruments Used:	Refer to section 5.11 for details.
Test Results:	Pass

Radiated Emission below 1GHz		
30MHz~1GHz, the worst case		
Test mode:	Transmitting mode(lowest channel)	Vertical



	Freq	Read Level	Factor	Level	Limit Line	Over Limit	Remark	Pol/Phase
	MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB		
1 pp	38.48	15.90	16.06	31.96	40.00	-8.04	Peak	VERTICAL
2	44.59	17.23	12.16	29.39	40.00	-10.61	Peak	VERTICAL
3	76.24	16.72	9.19	25.91	40.00	-14.09	Peak	VERTICAL
4	102.00	16.29	10.49	26.78	43.50	-16.72	Peak	VERTICAL
5	158.11	19.83	7.90	27.73	43.50	-15.77	Peak	VERTICAL
6	689.56	11.66	19.64	31.30	46.00	-14.70	Peak	VERTICAL

30MHz~1GHz, the worst case		
Test mode:	Transmitting mode (lowest channel)	Horizontal



		Freq	Read Level	Factor	Level	Limit Line	Over Limit	Remark	Pol/Phase
		MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB		
1	pp	31.95	10.25	18.75	29.00	40.00	-11.00	Peak	HORIZONTAL
2		80.93	13.73	9.91	23.64	40.00	-16.36	Peak	HORIZONTAL
3		162.04	21.38	7.76	29.14	43.50	-14.36	Peak	HORIZONTAL
4		354.18	11.48	13.63	25.11	46.00	-20.89	Peak	HORIZONTAL
5		520.89	11.24	17.29	28.53	46.00	-17.47	Peak	HORIZONTAL
6		726.81	10.56	19.98	30.54	46.00	-15.46	Peak	HORIZONTAL

Transmitter Emission above 1GHz

Worse case mode:	GFSK	Test channel:	Lowest

Frequency (MHz)	Meter Reading (dBμV)	Factor (dB)	Emission Level (dBμV/m)	Limits (dBμV/m)	Over (dB)	Detector Type	Ant. Pol. H/V
4804	49.24	-5.18	44.06	74	-29.94	peak	H
4804	37.11	-5.18	31.93	54	-22.07	AVG	H
7206	49.64	-6.45	43.19	74	-30.81	peak	H
7206	35.09	-6.45	28.64	54	-25.36	AVG	H
4804	49.78	-5.18	44.60	74	-29.40	peak	V
4804	37.49	-5.18	32.31	54	-21.69	AVG	V
7206	50.16	-6.45	43.71	74	-30.29	peak	V
7206	35.63	-6.45	29.18	54	-24.82	AVG	V

Frequency (MHz)	Meter Reading (dBμV)	Factor (dB)	Emission Level (dBμV/m)	Limits (dBμV/m)	Over (dB)	Detector Type	Ant. Pol. H/V
2390	48.96	-4.36	44.60	74	-29.40	peak	H
2390	35.10	-4.36	30.74	54	-23.26	AVG	H
2400	53.58	-4.36	49.22	74	-24.78	peak	H
2400	40.45	-4.36	36.09	54	-17.91	AVG	H
2390	46.50	-4.36	42.14	74	-31.86	peak	V
2390	36.14	-4.36	31.78	54	-22.22	AVG	V
2400	54.29	-4.36	49.93	74	-24.07	peak	V
2400	41.44	-4.36	37.08	54	-16.92	AVG	V

Worse case mode:	GFSK	Test channel:	Middle

Frequency (MHz)	Meter Reading (dBμV)	Factor (dB)	Emission Level (dBμV/m)	Limits (dBμV/m)	Over (dB)	Detector Type	Ant. Pol. H/V
4880	48.86	-5.19	43.67	74	-30.33	peak	H
4880	37.63	-5.19	32.44	54	-21.56	AVG	H
7320	49.15	-6.47	42.68	74	-31.32	peak	H
7320	35.59	-6.47	29.12	54	-24.88	AVG	H
4880	49.07	-5.19	43.88	74	-30.12	peak	V
4880	37.76	-5.19	32.57	54	-21.43	AVG	V
7320	48.69	-6.47	42.22	74	-31.78	peak	V
7320	36.26	-6.47	29.79	54	-24.21	AVG	V

Worse case mode:	GFSK	Test channel:	Highest

Frequency (MHz)	Meter Reading (dBμV)	Factor (dB)	Emission Level (dBμV/m)	Limits (dBμV/m)	Over (dB)	Detector Type	Ant. Pol. H/V
4960	49.79	-5.2	44.59	74	-29.41	peak	H
4960	38.86	-5.2	33.66	54	-20.34	AVG	H
7440	50.97	-6.47	44.50	74	-29.50	peak	H
7440	37.29	-6.47	30.82	54	-23.18	AVG	H
4960	50.49	-5.2	45.29	74	-28.71	peak	V
4960	37.05	-5.2	31.85	54	-22.15	AVG	V
7440	50.51	-6.47	44.04	74	-29.96	peak	V
7440	37.87	-6.47	31.40	54	-22.60	AVG	V

Frequency (MHz)	Meter Reading (dBμV)	Factor (dB)	Emission Level (dBμV/m)	Limits (dBμV/m)	Over (dB)	Detector Type	Ant. Pol. H/V
2483.5	57.51	-4.22	53.29	74	-20.71	peak	H
2483.5	44.81	-4.22	40.59	54	-13.41	AVG	H
2483.5	58.13	-4.22	53.91	74	-20.09	peak	V
2483.5	44.61	-4.22	40.39	54	-13.61	AVG	V

Remark:

1) The field strength is calculated by adding the Antenna Factor, Cable Factor & Preamplifier. The basic equation with a sample calculation is as follows:

   Final Test Level =Receiver Reading + Antenna Factor + Cable Factor – Preamplifier Factor

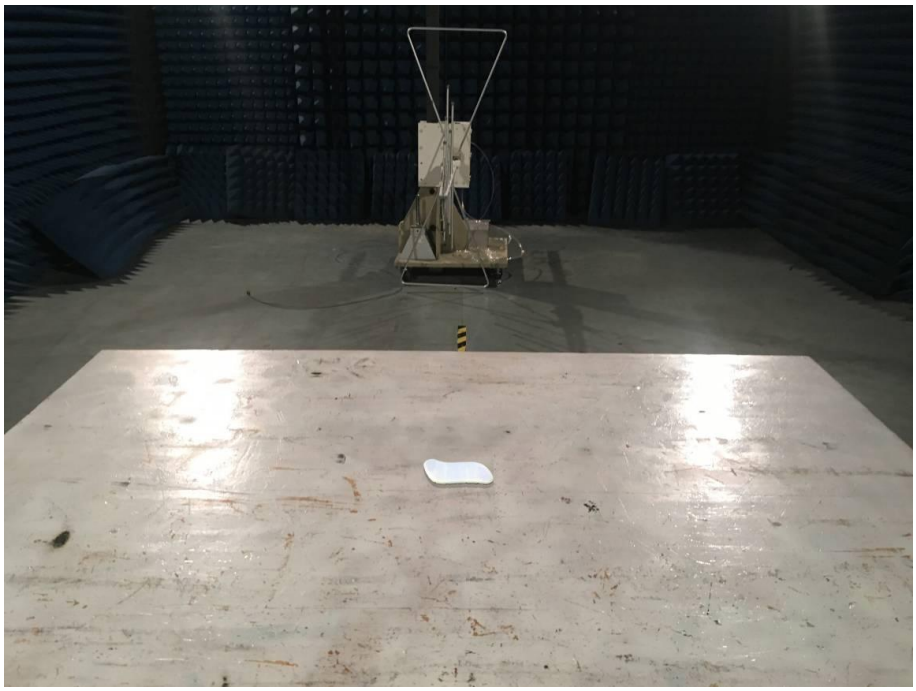
2) Scan from 9kHz to 25GHz, the disturbance above 13GHz and below 30MHz was very low, and the above harmonics were the highest point could be found when testing, so only the above harmonics had been displayed. The amplitude of spurious emissions from the radiator which are attenuated more than 20dB below the limit need not be reported.

7 Photographs - EUT Test Setup

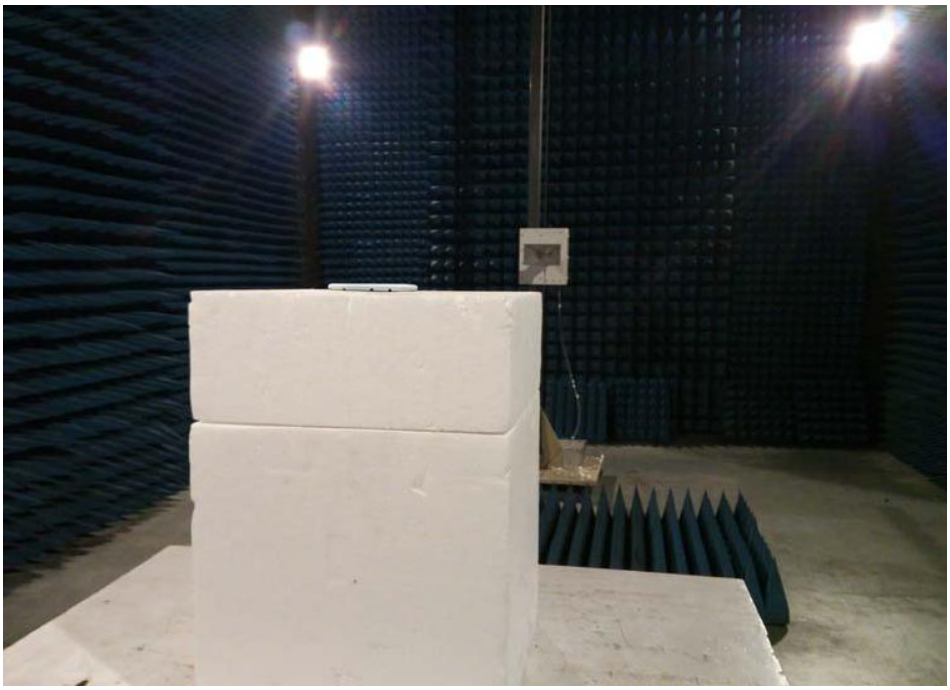
7.1 Radiated Spurious Emission

9KHz~30MHz:

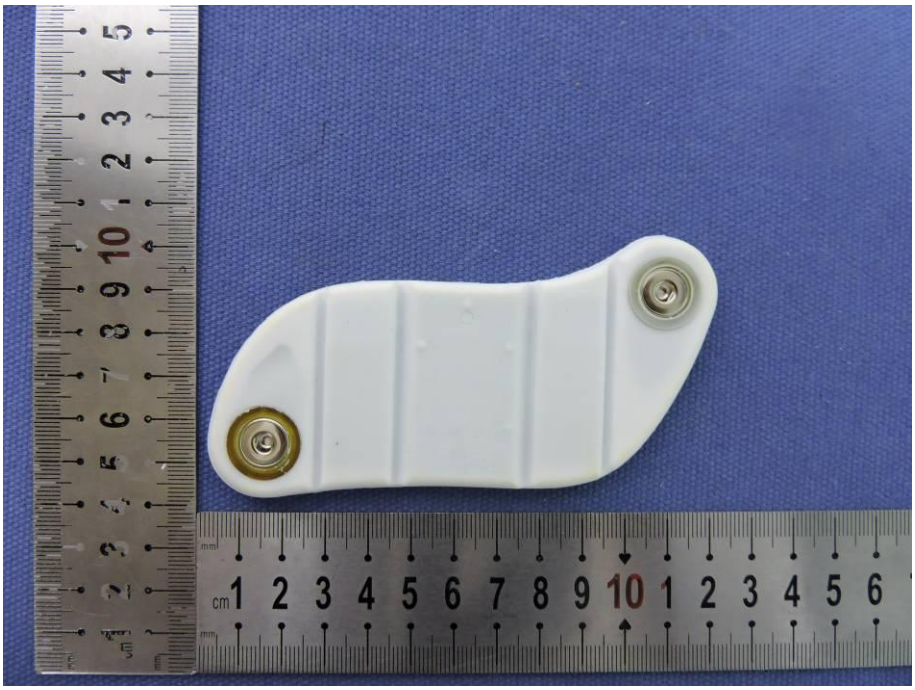
30MHz~1GHz:

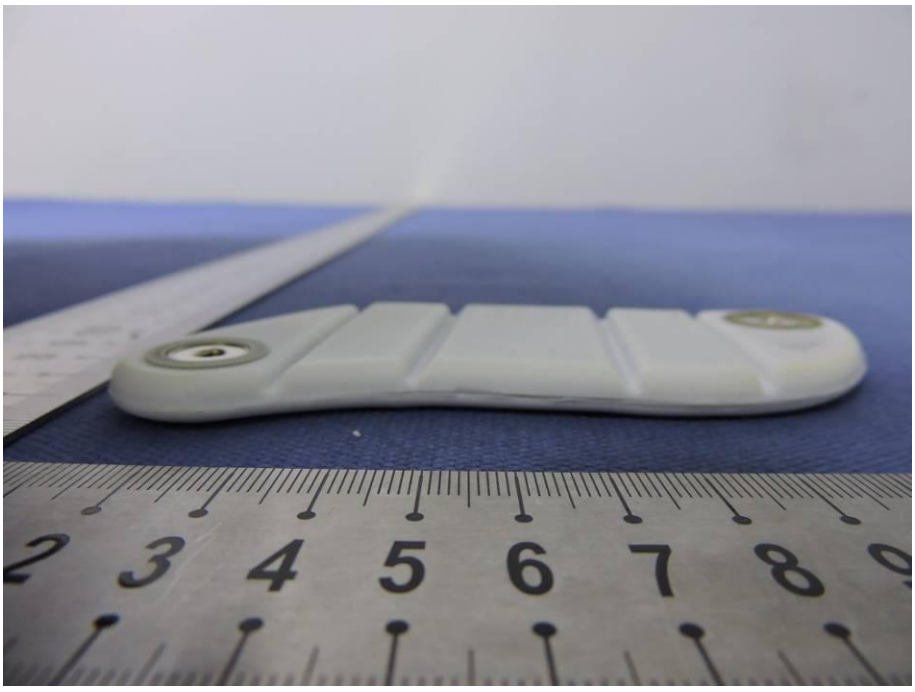


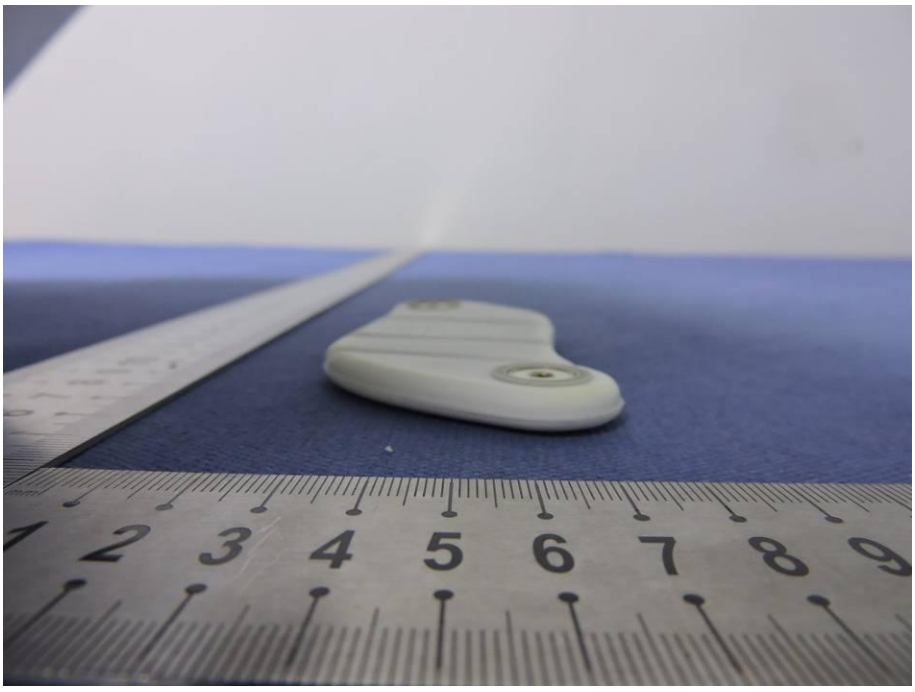
Above 1GHz:

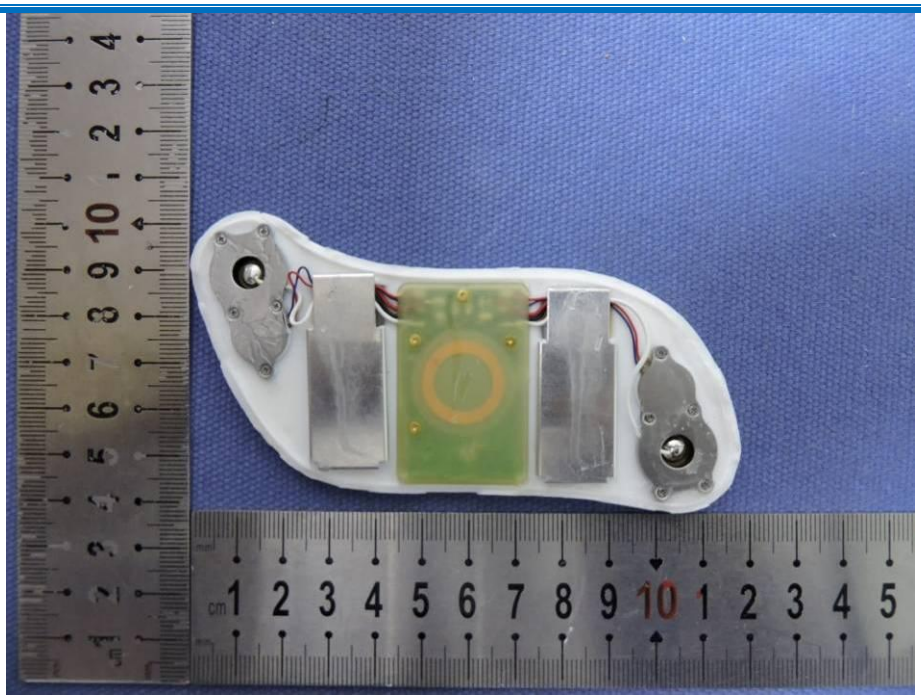


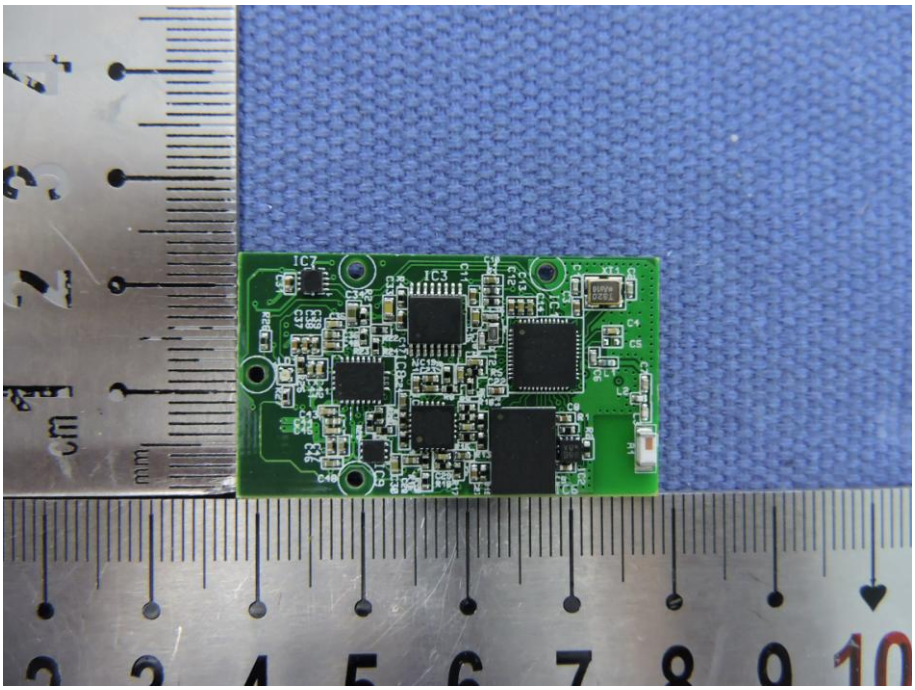
8 Photographs - EUT Constructional Details

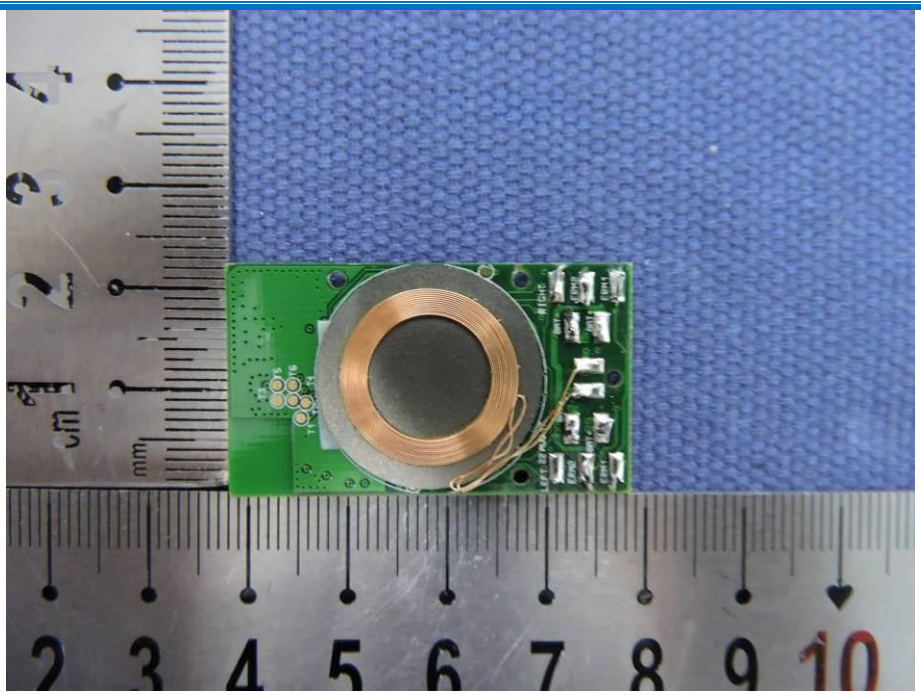


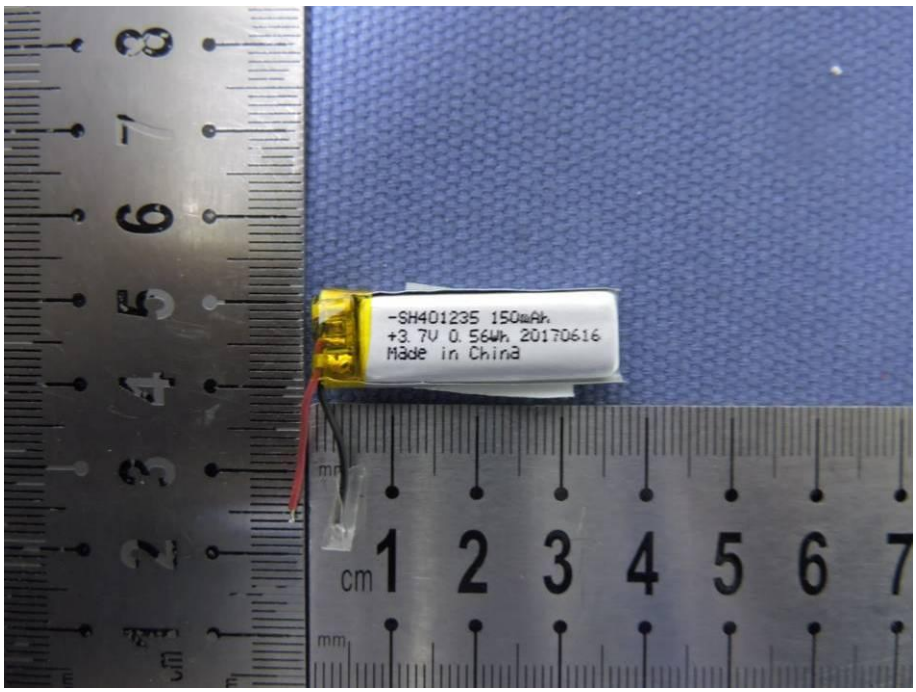








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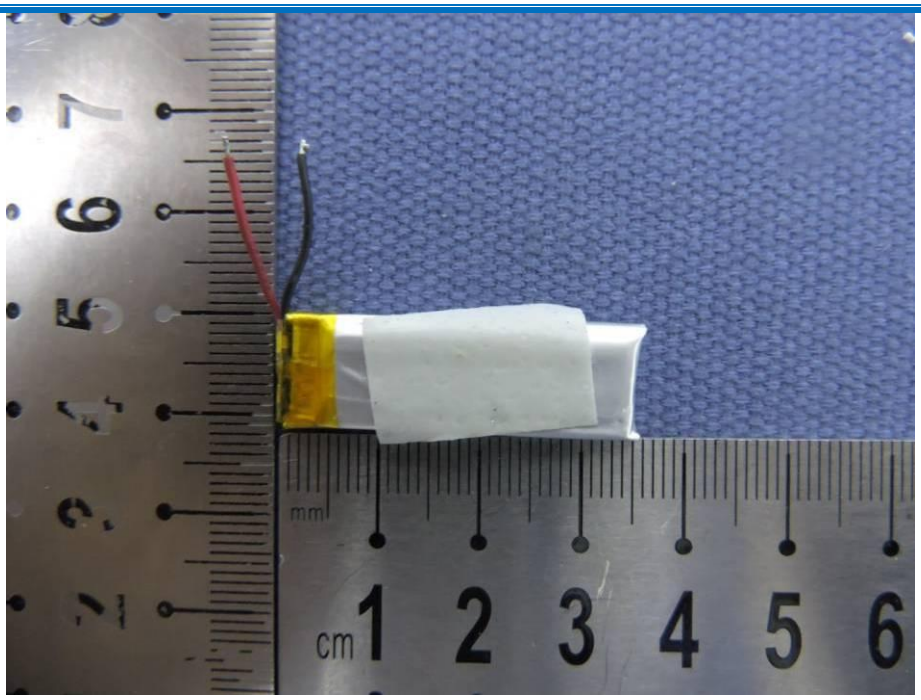
+3.7V 0.56Wh 20170616
Made in China



END OF THE REPORT